Listing of Claims:

This listing of claims will replace all prior versions, and listings, of claims in the applications:

- 1. (Previously amended) An apparatus to perform semiconductor processing, comprising:
 - a process chamber;
 - a plasma generator that can generate a plasma in the process chamber; and
 - a helical ribbon electrode coupled to an output of the plasma generator, wherein the electrode comprises a plurality of ribbon coils configured as stacked flat concentric spirals, each said ribbon coil having a width and a thickness, said width being greater than the thickness, said width being substantially perpendicular to the thickness, and said width being in a dimension facing an adjacent coil.
- (Original) The apparatus of claim 1, wherein the helical ribbon electrode is external to the process chamber.
- 3. (Original) The apparatus of claim 2, further comprising a dielectric wall position between the chamber and the helical ribbon electrode.
- 4. (Original) The apparatus of claim 3, wherein the dielectric wall is a flat plate.
- 5. (Original) The apparatus of claim 3, wherein the dielectric wall is concave.
- 6. (Original) The apparatus of claim 3, wherein the dielectric wall is convex.
- 7. (Original) The apparatus of claim 3, wherein the dielectric wall is a tube.
- 8. (Original) The apparatus of claim 7, wherein the dielectric wall projects through the center of the helical ribbon electrode.
- 9. (Original) The apparatus of claim 1, wherein the helical ribbon electrode is internal to the process chamber.

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- 10. (Original) The apparatus of claim 1, wherein the apparatus is adapted to receive a workpiece in the chamber and wherein the distance between the helical ribbon electrode and the workpiece is less than five inches.
- 11. (Previously amended) The apparatus of claim 1, wherein the apparatus is adapted to receive a workpiece in the chamber and wherein the distance between the helical ribbon electrode and the workpiece is approximately one to three inches.
- 12. (Original) The apparatus of claim 1, wherein the plasma generator pulses the helical ribbon electrode to perform pulse processing.
- 13. (Original) The apparatus of claim 1, further comprising a controller coupled to the control input of the plasma generator to control the generation of the plasma.
- 14. (Previously amended) The apparatus of claim 1, wherein the plasma generator is a radio frequency plasma generator.
- 15. (Original) The apparatus of claim 1, wherein the plasma generator is a solid state plasma generator without any moving parts and capable of short tuning response time.
- 16. (Original) The apparatus of claim 1, wherein the plasma generator is a solid state plasma generator employing frequency tuning to achieve output matching.
- 17.-20. (Cancelled)
- 21. (Previously amended) The apparatus of claim 1, wherein the helical ribbon electrode further comprises a cylindrical helix that forms a plurality of spiral turns in different planes.
- 22. (Previously presented) The apparatus of claim 21, wherein the spiral turns are essentially similar in size.
- 23. (Previously amended) The apparatus of claim 1, wherein the helical ribbon electrode has an elongated cross-section.
- 24. (Previously amended) A multi-layer processing chamber, comprising:
 - a gas source coupled to the chamber for introducing a processing gas into a reaction chamber, the reaction chamber having a sample disposed therein;

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- a solid state radio frequency plasma source coupled to the chamber to excite the processing gas;
- a helical ribbon electrode adapted to excite the plasma, the helical ribbon electrode comprising a plurality of ribbon coils stacked in flat concentric spirals, each said ribbon coil having a width and a thickness, said width being greater than the thickness, said width being substantially perpendicular to the thickness, and said width being in a dimension facing an adjacent coil; and
- a controller coupled to the solid state radio frequency plasma source to pulse the solid state radio frequency plasma source for each layer deposited on the sample.
- 25. (Previously amended) The apparatus of claim 1, wherein the width of the ribbon coils is substantially greater than the thickness of the ribbon coils.
- 26. (Previously amended) The apparatus of claim 1, wherein the ratio of the thickness to the width ranges up to 1:10,000.
- 27. (Previously amended) The apparatus of claim 24 wherein each of said plurality of ribbon coils has a width and a thickness, wherein the width is greater than the thickness.
- 28. (Previously amended) The apparatus of claim 24, wherein each of said plurality of ribbon coils has a width and a thickness, said width being substantially greater than the thickness.
- 29. (Previously amended) The apparatus of claim 24, wherein the ratio of the thickness to the width ranges up to 1:10,000.
- 30. (Previously presented) An improved apparatus for semiconductor processing, the improvement comprising a helical ribbon electrode, wherein the helical ribbon electrode comprises a compressed cylindrical helix having a plurality of flat concentric spiral coils separated from each other by a sheet of dielectric material, each said flat concentric spiral coil comprising a ribbon-like form, said ribbon-like form comprising a width and a thickness wherein the width is substantially greater than the thickness, the width lying in a plane that faces another of said plurality of flat concentric spiral coils, and the thickness corresponding to a plane that is substantially parallel to a direction of stacking of said plurality of flat concentric spiral coils.

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- 31. (Previously presented) An improved apparatus for semiconductor processing, the improvement comprising a helical ribbon electrode, wherein the helical ribbon electrode comprises a plurality of ribbon-shaped coils, each said coil being substantially wider than each said coil is thick, where a width corresponds to a plane that faces another of said plurality of ribbon-shaped coils, and a thickness corresponds to a plane that is substantially perpendicular to the width.
- 32. (Previously presented) An apparatus for semiconductor processing, the apparatus comprising:
 - a process chamber;
 - a solid state RF plasma generator coupled to the process chamber to excite a processing gas and generate a plasma;
 - a controller coupled to the solid state RF plasma generator to pulse the solid state radio frequency plasma generator for each deposited layer; and
 - a cylindrical helical ribbon electrode coupled to an output of the solid state radio frequency plasma generator, the cylindrical helical ribbon electrode further comprising:
 - a plurality of spirally-connected ribbon-shaped coils, each said coil having a width and a thickness;
 - the width substantially greater than the thickness and flat in a dimension facing another of said plurality of spirally-connected ribbon-shaped coils; and
 - the thickness is substantially perpendicular to the width,
 - wherein the cylindrical helical ribbon electrode is adapted to be placed within five inches of a sample situated in the process chamber.
- 33. (Previously presented) The apparatus of claim 32 wherein the cylindrical helical ribbon electrode is situated in an interior of the process chamber.
- 34. (Previously presented) The apparatus of claim 32 wherein the cylindrical helical ribbon electrode is situated on an exterior of the process chamber.

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- 35. (Previously presented) The apparatus of claim 32 wherein the a sheet of dielectric material separates adjacent said spirally-connected ribbon-shaped coils so that, when compressed, the adjacent surfaces of the spirally-connected ribbon-shaped coils do not touch.
- 36. (Previously presented) The apparatus of claim 35 wherein a width of the dielectric sheet is greater than the width of the spirally-connected ribbon-shaped coils.
- 37. (Previously presented) An improved electrode for coupling to the output of a generator, the improvement comprising a helical ribbon electrode further comprising:
 - a plurality of substantially flat, concentric, spirally-connected coils, said coils having a width and a thickness, the width being in a dimension facing an adjacent coil, and the thickness being perpendicular to the width, where the width is substantially greater than the thickness.
- 38. (Previously presented) An improved electrode for coupling to the output of a generator, the improvement comprising a helical ribbon electrode further comprising:
 - a plurality of substantially flat, concentric, spirally-connected coils, said coils having a width and a thickness, the width being in a dimension facing an adjacent coil, and the thickness being perpendicular to the width, where the width is substantially greater than the thickness; and
 - a sheet of dielectric material between adjacent coils.